

Notice of References Cited	Application/Control No. 10/068,803	Applicant(s)/Patent Under Reexamination TSIKOS ET AL.	
	Examiner Thien M. Le	Art Unit 2876	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,705,528	03-2004	Good et al.	235/472.01
	B	US-6,705,526	03-2004	Zhu et al.	235/472.01
	C	US-6,629,641	10-2003	Tsikos et al.	235/462.01
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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